

CIL  
EMU CRITICAL ITEMS LIST

12/24/91 SUPERSEDES RA/31/80

Page: 1  
Date: 12/11/91

SEM-4-001H  
Page 1643

CIL  
EMI CRITICAL ITEMS LIST

Page: 2  
Date: 12/13/91

Date: 12/13/98

NAME		FAILURE MODE & CAUSES	FAILURE EFFECT	RATIONALE FOR ACCEPTANCE
P/N	CRT			
QTY				
	2/2	440FM03;		cable insulation. Connector wiring is inspected before and after potting to insure there is no conductor damage and that the conductors are properly strain relieved and properly dressed to prevent conductor shorting to the adapter ring or an open circuit.
				Insulation resistance and dielectric strength are measured between each conductor and shield ground to insure there are no shorts prior to and after potting of the connectors.
				Contact crimp samples are made prior to the start of contact crimping and at the conclusion of crimping and subjected to a pull test to insure the crimping tools are operating properly. This insures there will not be any high resistance problems at the conductor.
				Strain relief cord length is checked to insure no loading placed on cables during pull testing.

### 9. Failure History -

100

**Related Failures:** RDR-8-EMU-44D-0002 (7-38-86) during CEN connector mate/demate cert cycle testing the shielding to the J10 connector was intermittently open after completing 1000 cycles. This failure was caused by a stiffening of the harness at the J10 connector from Styrostat that wicked up the cable during assembly. This reduced the effectiveness of the cable strain relief and made the cable/shield susceptible to breakage when bent at the J10 connector. ET163482-3 redesigns the J-10 connector to eliminate epoxy wicking by incorporating an all rubber strain relief boot.

#### **E. Ground Preparation:**

Tested per FFMU-A-001, SENU Communications and Biomed Check.

#### **f. Operational Map -**

#### Cream Report -

**PreEMI/EVA:** Trouble shoot problem, if no success, discontinue use of EVA. Consider third EVA if available.

## **Training -**

Standard EMU training covers this failure mode.

## **Operational Considerations -**

EMU - 1702

324-44-001H  
Page 1644

CSL  
EMI CRITICAL ITEMS LIST

Page: 3  
Date: 12/13/91

12/24/91 SUPERSEDES 08/31/90

ANALYST

NAME	P/H	R/H	CRIT	FAILURE MODE & CAUSES	FAILURE EFFECT	RATIONALE FOR ACCEPTANCE
			2/2	440FM03:		Flight rules define go/no go criteria related to EMI minimum communications. EVA checklist procedures verify hardware integrity and systems operational status prior to EVA.